

Notice of References Cited		Application/Control No. 09/013,819	Applicant(s)/Patent Under Reexamination OUDERKIRK ET AL.	
		Examiner Ricky D. Shafer	Art Unit 2872	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2,270,535	01-1942	Land et al	362/19
	B	US-3,801,036	04-1974	Hasler, Robin	242/525
	C	US-4,268,840	05-1981	Schank et al.	346/135.1
	D	US-4,842,781	06-1989	Nishizawa et al.	264/1.35
	E	US-4,871,406	10-1989	Griffith, Edwin D.	156/82
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	R. Guenther, "Modern Optics", John Wiley & Sons, New York, 1990, pp. 523 to 525 and pp. 533 to 534.
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.